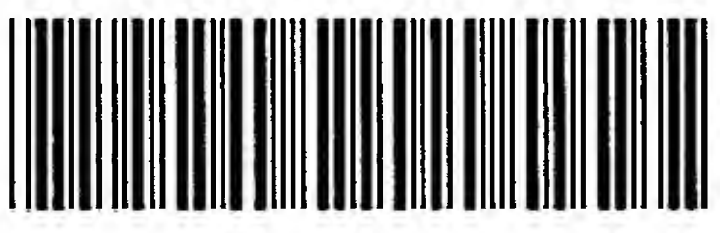


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/605,540	CHANG ET AL.	
	Examiner	Art Unit	
	Paula W. Klimach	2135	

SEARCHED			
Class	Subclass	Date	Examiner
380	37, 44	10/23/2006	PWK

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East	10/23/2006	PWK
Google	10/23/2006	PWK
IEEE	10/23/2006	PWK
ACM	10/23/2006	PWK
Continuity Data	10/23/2006	PWK
Inventor Name Search	10/23/2006	PWK
Plus Search	10/23/2006	PWK